



SUPPLEMENTAL APPLICATION DATA SHEET

APPLICATION INFORMATION

Application Number:: 10/554,620
Application Date:: 10/27/05
Application Type:: REGULAR
Subject Matter:: UTILITY
CD-ROM or CD-R?: NONE
Title:: DYNAMIC MATRIX SENSITIVITY
MEASURING INSTRUMENT FOR
INERTIAL SENSORS, AND
MEASURING METHOD THEREFOR
Attorney Docket Number:: 280512US2PCT
Total Drawing Sheets:: 9

INVENTOR INFORMATION

Applicant Authority Type:: INVENTOR
Primary Citizenship Country:: Japan
Status:: FULL CAPACITY
Given Name:: Akira
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1-chome, Tsukuba-shi
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CORRESPONDENCE INFORMATION

Correspondence Customer Number:: 22850

REPRESENTATIVE INFORMATION

Representative Customer Number:: 22850

DOMESTIC PRIORITY INFORMATION

Application::	Continuity Type::	Parent Application::	Parent Filing Date::
This Application	National Stage of	PCT/JP04/06148	04/28/04

FOREIGN PRIORITY INFORMATION

Application Number:	Country::	Filing Date::	Priority Claimed::
2003-123417	Japan	04/28/03	YES
2003-360287	Japan	10/21/03	YES

ASSIGNMENT INFORMATION

Assignee Name::	National Inst. of Adv. Industrial Science & Tech.
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